TITLE:
Improvement of Reversible Strain Limit for Critical Current of DI-BSCCO Due to Lamination Technique

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Improvement of Reversible Strain Limit for Critical Current of DI-BSCCO Due to Lamination Technique


Abstract—The DI (dynamically innovative)-BSCCO-Bi2223 tapes achieved high critical current as well as high modulus of elasticity. Further the reversible strain limit and the corresponding stress for critical current have been remarkably increased by means of lamination technique. During the course of development, their optimized architecture has been designed based on the principle of the rule of mixture for maximizing the force free strain exerted on the superconducting component. The reversible strain/stress limit \( \left( \Delta \varepsilon_{\text{rev}} / \Delta \sigma_{\text{rev}} \right) \) was defined as a strain, at which the critical current recovers to the level of 99% \( I_{\text{co}} \). Selecting several kinds of laminating materials and changing condition of the fabrication, the excellent Cu alloy-3ply tape with \( I_{\text{co}} \) of 311 A/cm was realized of which \( \Delta \varepsilon_{\text{rev}} \) and \( \Delta \sigma_{\text{rev}} \) reached 0.42% and 300 MPa, respectively. Further during the theoretical analysis, the increase of reversible strain limit was made clear to be attributed to the increase of thermally induced residual strain as well as the compensation effect of laminated layers against a local fracture mode.

Index Terms—BSSCO-Bi2223, critical current, force free strain, modulus of elasticity, residual strain.

I. INTRODUCTION

High critical current DI-BSCCO-Bi2223 tapes have been successfully developed on the basis of controlled over-pressure (CT-OP) technology. Voids included in the Bi2223 filaments were remarkably reduced and volume fraction of non-superconducting phases was reduced. Consequently the high modulus of elasticity and the high critical current have been realized. In order to improve further their performances, the residual stress/strain control as well as high strengthening is important issue to develop tapes with high tolerance against strain/stress. Due to the difference of coefficient of thermal expansion (CTE), a compressive strain is exerted on the superconducting (SC) component. As this compressive strain generates advantage to get the high performance, the high-alloying of the coverage layer and the lamination of metallic foil have been applied. In order to analyse the residual strain/stress effect, various models have been developed [1]–[3]. Some attempts to measure directly the residual strain exerted on the BSCCO component were carried out by diffraction techniques using synchrotron radiation and neutron beam [4]–[7]. However it is still necessary to get quantitative knowledge on the strain/stress effect with electromagnetic property in order to design the further higher performance tapes.

In the present study, the DI-BSCCO-Bi2223 tapes with different kinds of laminated layer have been investigated in order to make clear their mechanical property and its influence to critical current, and to discuss the improvement of reversible strain limit.

II. EXPERIMENTAL PROCEDURE

Five types of DI-BSCCO composite superconductors have been examined. Their architecture is as follows; the insert tape consists of three components; superconducting filaments (component number 1) embedded in silver matrix (2) and the outer silver alloy (3). Four kinds of metallic foils (Brass, Sn bearing Cu and SUS) were used for the lamination. Their foil thickness was 20, 50 or 100 \( \mu \text{m} \). One of these foils (5) was laminated by using the solder (4). The sample name, for instance, SUS20 indicates that the insert tape is soldered by stainless steel foils with thickness of 20 \( \mu \text{m} \).

Tensile test was carried out at room temperature by using tensile machine Shimadzu AG-50kNIS installed with 1 kN load cell. The initial distance between chucks was kept as 100 mm. The Nyilas type double extensometer \( (\text{GL} = 25 \text{ mm}) \) was attached at the center of sample. The initial cross head speed was selected usually as \( 8 \times 10^{-4} \text{[mm/s]} \).

The critical current measurement was carried out under tensile load in order to investigate the change of \( I_{\text{c}} \) as a function of uniaxial tensile strain. The critical current was determined with a criterion of 0.1 mV/m and the \( n \) value was given from the slope of \( I-I-V \) curve between 0.1 and 1 mV/m. The construction of experimental apparatus was similar to that for tensile test at room temperature mentioned above. In this experiment, two chucking parts were electrically isolated from the tensile machine. Two voltage taps were soldered on the tape outside the extensometers. The length of voltage taps was about 60 mm. The sample was immersed in the liquid nitrogen by using an open cryostat.

The precise measurement of lattice constant was carried out at Residual Stress Analysis (RESA) station in research reactor JRR-3 of JAEA. The residual strain of Bi filaments was determined by comparing the lattice constant of the powder samples extracted from the same insert tapes investigated in the present...
TABLE I
MECHANICAL PROPERTIES AT ROOM TEMPERATURE

<table>
<thead>
<tr>
<th>Sample</th>
<th>Experiments</th>
<th>Calculation</th>
</tr>
</thead>
<tbody>
<tr>
<td></td>
<td>$\varepsilon_0$</td>
<td>$R_{0.2}$</td>
</tr>
<tr>
<td>Insert</td>
<td>86</td>
<td>(118)</td>
</tr>
<tr>
<td>Brass50</td>
<td>89</td>
<td>268</td>
</tr>
<tr>
<td>Brass100</td>
<td>96</td>
<td>272</td>
</tr>
<tr>
<td>Sn bearing Cu50</td>
<td>94</td>
<td>230</td>
</tr>
<tr>
<td>SUS20</td>
<td>97</td>
<td>258</td>
</tr>
</tbody>
</table>

TABLE II
RESIDUAL STRAIN EXERTED ON THE SC COMPONENT AT ROOM TEMPERATURE
AND 77 K

<table>
<thead>
<tr>
<th>Sample</th>
<th>Calculation</th>
<th>Experiments</th>
</tr>
</thead>
<tbody>
<tr>
<td></td>
<td>$A_{11}$ at RT (%)</td>
<td>$A_{11}$ at 77K (%)</td>
</tr>
<tr>
<td>Insert</td>
<td>-0.055</td>
<td>-0.099</td>
</tr>
<tr>
<td>Brass50</td>
<td>-0.081</td>
<td>-0.146</td>
</tr>
<tr>
<td>Brass100</td>
<td>-0.088</td>
<td>-0.158</td>
</tr>
<tr>
<td>Sn bearing Cu50</td>
<td>-0.053</td>
<td>-0.095</td>
</tr>
<tr>
<td>SUS20</td>
<td>-0.052</td>
<td>-0.094</td>
</tr>
</tbody>
</table>
| Insert [1]   | -0.059      | -0.107      | -0.0069     

study. The details of the strain measurement will be reported elsewhere [6].

III. EXPERIMENTAL RESULTS AND DISCUSSION

A. Mechanical Properties

Stress—strain behavior at room temperature is given in Table I all the tapes. Here the modulus of elasticity, $\varepsilon_0$, was estimated from the initial slope. The 0.2% yield stress, $R_{0.2}$, and strain $A_{0.2}$ are given here, while the insert tape fractured at the stress/strain indicated in the parentheses.

The initial slope was experimentally determined as $\varepsilon_0$ as listed in Table I. On the other hand, this initial slope is given by the equation for both insert and laminated tapes [1],

$$\varepsilon_0 \cong E_1V_{f1} + E_3V_{f3} + E_5V_{f5} \quad (1)$$

where $E_i$ and $V_{fi}$ are the modulus of elasticity and volume fraction of component $i$. The calculated results are listed in Table I, where the physical parameters necessary to the calculation were selected from the [1]. Both experimental and theoretical values are identical each other. This indicates that the modulus of elasticity is mainly contributed from three components of BSCCO, the silver alloy and the laminated alloy.

B. Analysis of Residual Strain

In order to understand fully the mechanical properties of the present composite superconductors, it is necessary to analyse the thermally induced residual strain during the fabrication process. The process applied to the insert tapes is as follows. Firstly all the tapes were cooled down to 77 K from the heat treatment temperature $T_\lambda$ in order to measure the critical current at the manufacturer’s laboratory. After that, they were delivered outside. At room temperature, mechanical test was carried out at our laboratory. Then critical current as well as mechanical test were carried out at 77 K.

During the heat treatment, the internal residual strain/stress generates in each component due to the difference of the coefficient of thermal expansion (CTE). The procedure to calculate residual strain/stress has been previously reported by our groups [1], [2] At high temperature, however, residual stress should be thermally relaxed. The residual strain/stress start to accumulate in the tape practically at $T_0$. In the previous paper [1], 563 K has been fixed as $T_0$ for the similar BSCCO tapes. In the present analysis, $T_0$ was assumed to be the same value. As discussed below, some correction will be applied.

As mentioned previously, the procedure to get exactly the residual strain is very time-consuming. So the approximated expression was proposed in order to evaluate the residual strain exerted on the SC component. The following equation is given for both the insert and laminated tapes,

$$A_{r1} = \frac{(\alpha_3 - \alpha_1)E_3V_{f3} + (\alpha_5 - \alpha_1)E_5V_{f5}}{\varepsilon_0} \Delta T \quad (2)$$

where $\alpha_i$ is the CTE of component $i$. $\Delta T$ is equal to 298 (or 77) —$T_0$. The results are listed in Table II. As a summary, the residual strain exerted on the SC component is compressive and their magnitude increases by the lamination. When the tensile strain is applied to the tape, the compressive strain exerted on the SC component decreases and reaches zero, then the strain changes tensile component. This specific strain is called the force free strain $A_{ff}$ and it is given by

$$A_{ff} = -A_{r1} \quad (3)$$

C. Strain Measurement by Neutron Diffraction

The precise lattice constant for BSCCO (220) was measured under the geometry as the scattering vector is parallel to the longitudinal axis of the tape and to the tape surface. So the change of lattice constant was detected parallel to the longitudinal axis of the tape and to the tape surface. The results are listed in Table II together with the calculated results obtained in the present residual strain analysis. In the case of the insert tape, both results were very different each other. This discrepancy has been discussed to be related to the thermally induced relaxation at room temperature [1]. It is interesting to know that the residual strains determined from neutron diffraction are larger within 40% than the calculated ones except the case of insert tape.
D. Critical Currents

Fig. 1 shows the strain dependence of normalized critical currents for four Sn bearing Cu50 tapes. In general, the critical current decreased gradually in the reversible region and abruptly it decreased beyond critical strain due to the fracture of BSCCO filaments as reported elsewhere [1]. Fig. 2 is the enlarged picture of the normalized critical current vs applied stress for the Sn bearing Cu tapes. Similarly the critical current decreased gradually as a function of stress and dropped down due to the macroscopic fracture of BSCCO filaments. Fig. 3 shows the change of the n value as a function strain. The n value was almost constant in the reversible region.

The same measurements have been carried out for other tapes. Table III shows the summary for the initial values of critical current and the n value. Comparing the data for the insert tapes with those for the laminated tapes, both quantities are almost the same for each other. This indicates that the tapes did not degrade during the lamination process. Here the engineering critical current $J_c$ is defined as the critical current divided by the cross sectional area of the tape. The $J_c$ became smaller because of the increase of tape thickness due to the lamination.

E. Reversible Strain Limit

The strain tolerance for critical current was determined as follows. As shown in Fig. 4, the sample was loaded up to a certain strain level and there the $I - V$ characteristic curve was measured to determine $I_c$ as indicated by the sign G. Then the load was released to zero level, until the strain was reduced to a permanent strain, where the $I_c$ was measured as indicated by the

<table>
<thead>
<tr>
<th>Sample</th>
<th>Number of Tapes Tested</th>
<th>$I_c$ (A)</th>
<th>$n_c$</th>
<th>$J_c$ (A/mm$^2$)</th>
</tr>
</thead>
<tbody>
<tr>
<td>Insert</td>
<td>4</td>
<td>139.7</td>
<td>22.4</td>
<td>149.0</td>
</tr>
<tr>
<td>Brass50</td>
<td>3</td>
<td>141.2</td>
<td>22.3</td>
<td>93.6</td>
</tr>
<tr>
<td>Brass100</td>
<td>3</td>
<td>140.6</td>
<td>22.8</td>
<td>69.8</td>
</tr>
<tr>
<td>Sn bearing Cu50</td>
<td>4</td>
<td>140.8</td>
<td>22.5</td>
<td>89.1</td>
</tr>
<tr>
<td>SUS20</td>
<td>3</td>
<td>136.8</td>
<td>22.2</td>
<td>110.5</td>
</tr>
</tbody>
</table>
sign H. This procedure was repeated. When the critical current at the point H is 99% of the initial value \( I_{C(0)} \), the strain at the point G is defined as \( A_{RV} \). This 99% \( I_c \) recovery criterion has been accepted by several authors [7] for discussing the transport properties of YBCO coated conductors. Another conventional criterion has been used as the 95% \( I_c \) retention. This point is indicated in Fig. 4. It is clear that the tape has already fractured at this point. Their critical values are summarized in Table IV.

It has been made clear that the lamination improves the strain/stress dependence of critical current as summarized in Table IV. As discussed previously [1], [5], the relation between the force free strain and the reversible strain is given by the equation:

\[
\Delta A = A_{RV} - A_{ff}
\]

which indicates the tensile strain exerted on the SC component. As summarized in Table V, this quantity became about 0.1% for the insert tapes, while it increased almost by 2 times by the lamination. When tensile load is applied to the tape and the strain exceeds the force free strain, the BSCCO filaments start to be pulled by tensile stress. That is, the fracture strength of filaments is given by \( \Delta A E_f \). In the case of insert tapes, it is 160 MPa, while it becomes 400–450 MPa for the laminated tapes. Those experimental facts suggest the change to the uniform plastic deformation process, the work-hardening takes place uniformly and then a locally concentrated fracture mode is prevented.

### F. Estimation of \( T_0 \)

In the present residual strain analysis, the temperature \( T_0 \) was a priori assumed to be 563 K. In order to estimate the real number of \( T_0 \), it is reasonable to use the approximate expressions (2). By inputting the observed residual strain listed in Table II, \( T_0 \) was re-estimated to be ranged between 628 and 754 K. Thus when the residual strain can be experimentally obtained by the precise lattice constant measurement by neutron beam or synchrotron radiation, it is easy to know the initial value \( T_0 \).

### IV. Conclusion

The major conclusions obtained here are as follows:

1) Residual strains exerted on the SC component were calculated according to a simple model based on the rule of mixture. The observed residual strains by the neutron diffraction technique were found to be larger within 40% than the calculated values.

2) Strain and stress dependence of critical currents had good correlation with the change of force free strain in the BSCCO component. The difference between the strain corresponding to the 99% \( I_c \) recovery and the force free strain was explained as the fracture strain of BSCCO filaments.

3) Improvement of residual strain limits could be explained in terms of the increase of force free strain and the homogenization effect of fracture behavior due to the lamination.

### References


